

Search Notes

Application/Control No.

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Examiner

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Applicant(s)/Patent under
Reexamination

CHO, JANG-HO

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
712	205	4/16/2007	BPG

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB text search		4/16/2007	BPG

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search	4/16/2007	BPG
NPL search (Google Scholar, IEEE Xplore)	4/16/2007	BPG
Inventor name search	4/9/2007	BPG